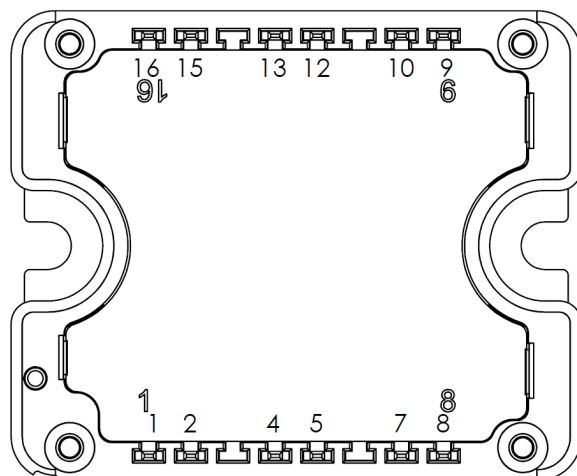
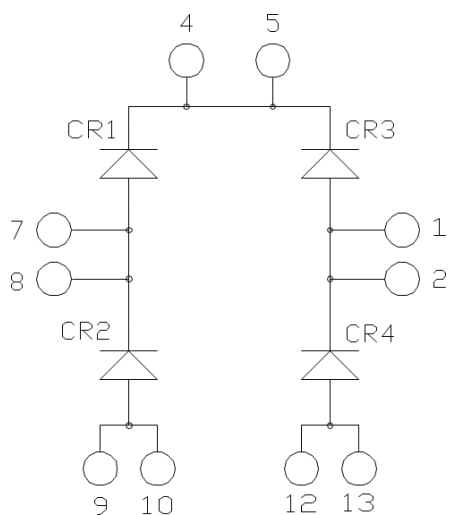


MSCDC50H1201AG SiC Diode Full Bridge Power Module

1 Product Overview

This section shows the product overview for the MSCDC50H1201AG device.



All ratings at $T_j = 25^\circ\text{C}$, unless otherwise specified.

Caution: These devices are sensitive to electrostatic discharge. Proper handling procedures should be followed.

1.1 Features

The following are key features of the MSCDC50H1201AG device:

- Silicon Carbide (SiC) Schottky Diode
 - Zero reverse recovery
 - Zero forward recovery
 - Temperature independent switching behavior
 - Positive temperature coefficient on VF
- High blocking voltage
- Very low stray inductance
- Aluminum nitride (AlN) substrate for improved thermal performance

1.2 Benefits

The following are benefits of the MSCDC50H1201AG device:

- Outstanding performance at high frequency operation
- Solderable terminals for easy PCB mounting
- Direct mounting to heatsink (isolated package)
- Low profile
- RoHS compliant

1.3 Applications

The MSCDC50H1201AG device is designed for the following applications:

- Uninterruptible power supply (UPS)
- Induction heating
- Welding equipment
- High-speed rectifiers

2 Electrical Specifications

This section shows the electrical specifications for the MSCDC50H1201AG device.

2.1 Absolute Maximum Ratings

The following table shows the absolute maximum ratings per SiC diode for the MSCDC50H1201AG device.

Table 1 • Absolute Maximum Ratings

Symbol	Parameter	Maximum Ratings	Unit
V_{RRM}	Repetitive peak reverse voltage	1200	V
I_F	DC forward current	$T_C = 100\text{ }^{\circ}\text{C}$ 50	A

The following table shows the thermal and package characteristics of the MSCDC50H1201AG.

Table 2 • Thermal and Package Characteristics

Symbol	Characteristic	Min	Max	Unit
V_{ISOL}	RMS isolation voltage, any terminal to case $t = 1$ minute, 50 Hz/60 Hz	4000		V
T_J	Operating junction temperature range	-40	175	$^{\circ}\text{C}$
T_{JOP}	Recommended junction temperature under switching conditions	-40	$T_{Jmax} - 25$	
T_{STG}	Storage temperature range	-40	125	
T_C	Operating case temperature	-40	125	
Torque	Mounting torque	To heatsink	M4 2 3	N.m
Wt	Package weight		80	g

2.2 Electrical Performance

The following table shows the electrical characteristics per SiC diode of the MSCDC50H1201AG.

Table 3 • Electrical Characteristics Per Diode

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V_F	Diode forward voltage	$I_F = 50\text{ A}$ $T_J = 25\text{ }^{\circ}\text{C}$		1.5	1.8	V
		$T_J = 175\text{ }^{\circ}\text{C}$		2.1		
I_{RM}	Reverse leakage current	$V_R = 1200\text{ V}$ $T_J = 25\text{ }^{\circ}\text{C}$		15	200	μA
		$T_J = 175\text{ }^{\circ}\text{C}$		250		
Q_C	Total capacitive charge	$V_R = 600\text{ V}$		224		nC
C	Total capacitance	$f = 1\text{ MHz}, V_R = 400\text{ V}$		246		pF
		$f = 1\text{ MHz}, V_R = 800\text{ V}$		182		
R_{thJC}	Junction-to-case thermal resistance				0.56	$^{\circ}\text{C/W}$

2.3 Performance Curves

This section shows the typical performance curves for the MSCDC50H1201AG device.

Figure 1 • Maximum Transient Thermal Impedance

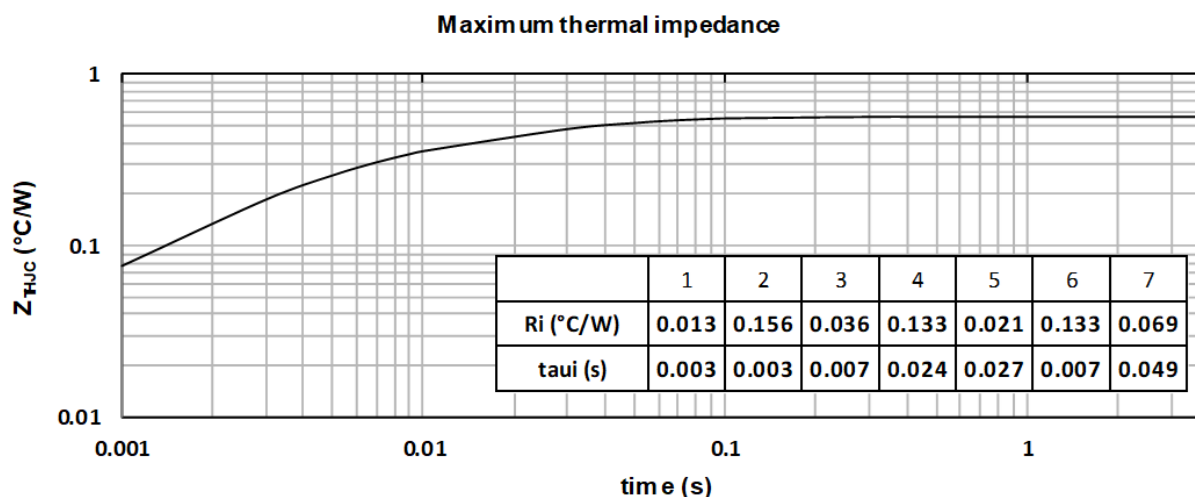


Figure 2 • Forward Current vs Forward Voltage

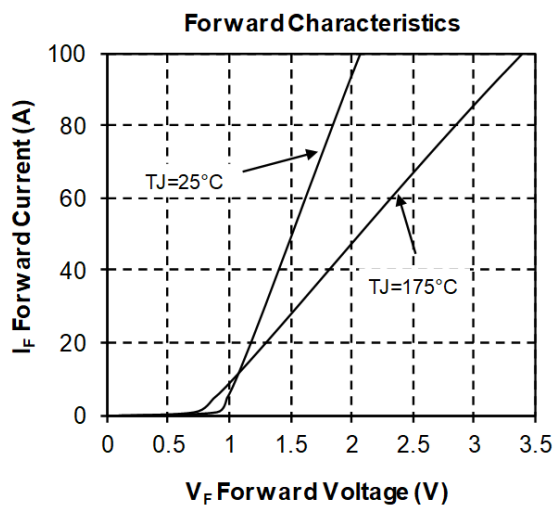
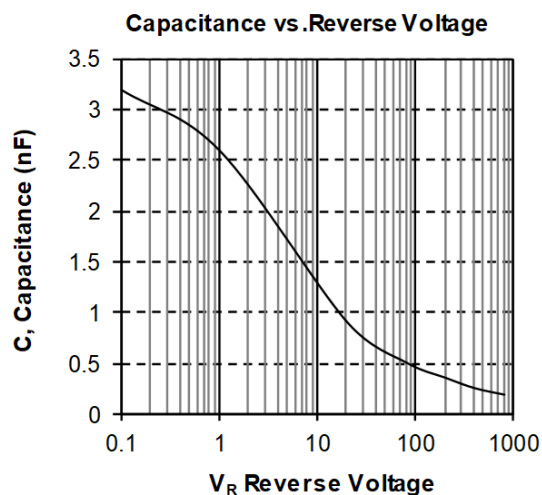


Figure 3 • Capacitance vs. Reverse Voltage



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